

#### **General Description**

The WSP9435 is the highest performance trench P-Ch MOSFET with extreme high cell density , which provide excellent RDSON and gate charge for most of the synchronous buck converter applications .

The WSP9435 meet the RoHS and Green Product requirement , with full function reliability approved.

#### Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- Green Device Available

# **Product Summery**

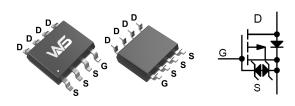
BVDSS	RDSON ID	
-30V	38mΩ	-5.4A

## Applications

Power Management in Notebook Computer,
Portable Equipment and Battery Powered
Systems

• ESD:2KV

## **SOP-8 Pin Configuration**



## **Absolute Maximum Ratings**

Symbol	Parameter	Rating	Units	
V <sub>DS</sub>	Drain-Source Voltage	-30	V	
V <sub>GS</sub>	Gate-Source Voltage	±20	V	
I <sub>D</sub> @T <sub>A</sub> =25℃	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup>	-5.4	А	
I <sub>D</sub> @T <sub>A</sub> =70℃	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup>	-4.5	A	
I <sub>DM</sub>	Pulsed Drain Current <sup>1,2</sup>	-21	А	
P <sub>D</sub> @T <sub>A</sub> =25℃	Total Power Dissipation <sup>3</sup>	2.5	W	
T <sub>STG</sub>	Storage Temperature Range -55 to 150		°C	
TJ	Operating Junction Temperature Range	-55 to 150	°C	

## **Thermal Data**

Symbol	Parameter	Тур.	Max.	Unit
R <sub>0JA</sub>	Thermal Resistance Junction-Ambient <sup>1</sup>		80	°C/W
R <sub>θJC</sub>	Thermal Resistance Junction-Case <sup>1</sup>		30	°C/W



**WSP9435** 

P-Ch MOSFET

## Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS}$ =0V , I <sub>D</sub> =-250uA	-30			V
$\triangle BV_{DSS} / \triangle T_J$	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25 $^\circ\!\mathrm{C}$ , I_D=-1mA		-0.023		V/℃
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =-10V , I <sub>D</sub> =-5.4A		38	48	mΩ
		V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-2A		60	78	
V <sub>GS(th)</sub>	Gate Threshold Voltage	—V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =-250uA	-1.0	-1.5	-2.3	V
$ riangle V_{GS(th)}$	V <sub>GS(th)</sub> Temperature Coefficient			4		mV/℃
	Drain-Source Leakage Current	$V_{\text{DS}}\text{=-24V}$ , $V_{\text{GS}}\text{=}0\text{V}$ , $T_{\text{J}}\text{=}25^\circ\!\mathbb{C}$			-1	uA
I <sub>DSS</sub>		$V_{DS}$ =-24V , $V_{GS}$ =0V , T <sub>J</sub> =55 $^\circ \! \mathbb{C}$			-5	
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS}$ = $\pm20V$ , $V_{DS}$ =0V			±100	nA
gfs	Forward Transconductance	V <sub>DS</sub> =-5V , I <sub>D</sub> =-4A		11		S
Qg	Total Gate Charge (-4.5V)	V <sub>DS</sub> =-15V , V <sub>GS</sub> =-10V , I <sub>D</sub> =-5.4A		13	19	nC
Q <sub>gs</sub>	Gate-Source Charge			1.3	2.2	
Q <sub>gd</sub>	Gate-Drain Charge			3.1	2.7	
T <sub>d(on)</sub>	Turn-On Delay Time			8	9.6	
Tr	Rise Time	$V_{DD}\text{=-}15V$ , $V_{GS}\text{=-}10V$ , $R_{G}\text{=}6\Omega,$		13	15.1	ns
T <sub>d(off)</sub>	Turn-Off Delay Time	I <sub>D</sub> =-1A ,R∟=10Ω.		26	36	115
T <sub>f</sub>	Fall Time			7	12.0	
C <sub>iss</sub>	Input Capacitance			642		
Coss	Output Capacitance	V <sub>DS</sub> =-15V , V <sub>GS</sub> =0V , f=1MHz		76		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			66		

## **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current <sup>1,4</sup>				-2.0	А
I <sub>SM</sub>	Pulsed Source Current <sup>2,4</sup>	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			-21	А
V <sub>SD</sub>	Diode Forward Voltage <sup>2</sup>	$V_{GS}$ =0V , $I_{S}$ =-1A , $T_{J}$ =25 $^{\circ}$ C			-1.2	V
t <sub>rr</sub>	Reverse Recovery Time			13		nS
Qrr	Reverse Recovery Charge	l⊧=-5.4A,dl/dt=100A/µs , Tյ=25℃		7		nC

Note :

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper ,t $\leq$ 10sec.

2.The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2% 3.The power dissipation is limited by 150°C junction temperature

4. The data is theoretically the same as  $I_{\text{D}}$  and  $I_{\text{DM}}$  , in real applications , should be limited by total power dissipation.



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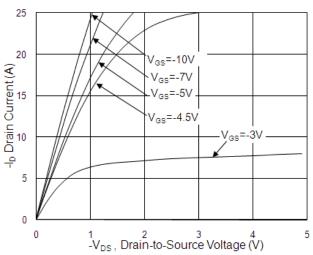


Fig.1 Typical Output Characteristics

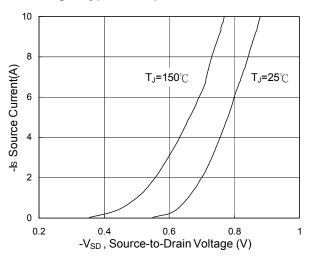


Fig.3 Forward Characteristics of Reverse

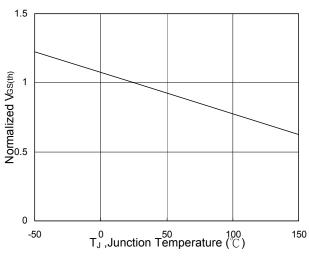


Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$ 

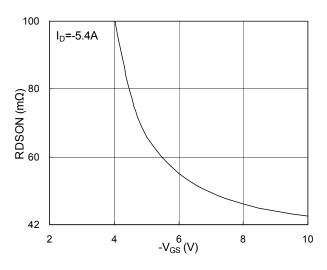


Fig.2 On-Resistance vs. Gate-Source

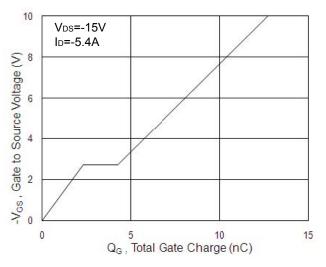


Fig.4 Gate-Charge Characteristics

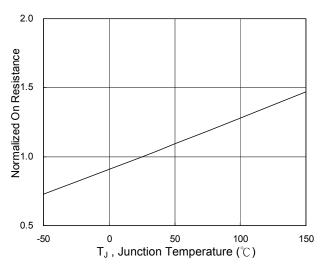


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>



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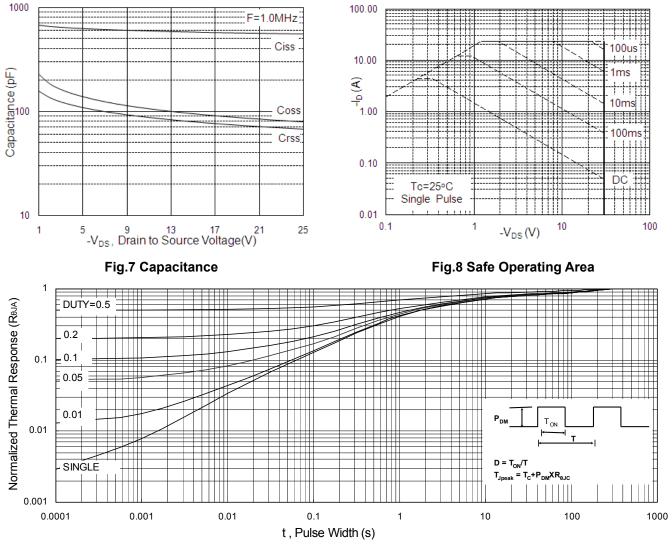
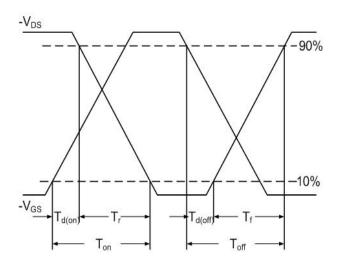
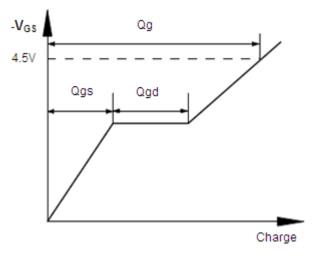


Fig.9 Normalized Maximum Transient Thermal Impedance







## Fig.11 Gate Charge Waveform



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